

FDS6675 Single P-Channel, Logic Level, PowerTrench[™] MOSFET

General Description

This P-Channel Logic Level MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

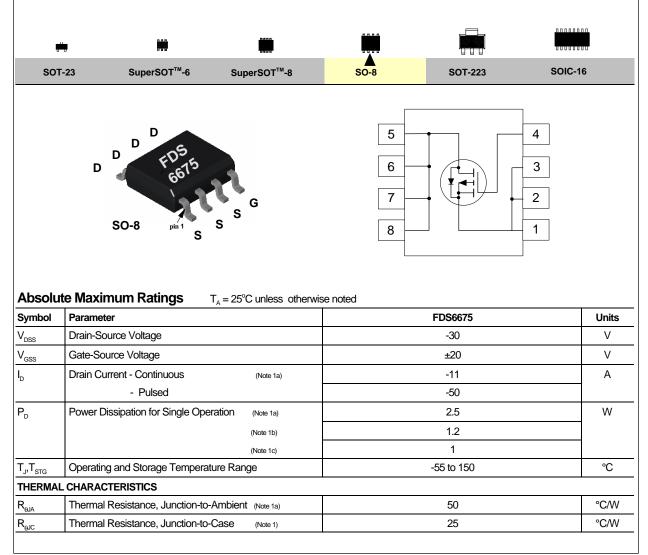
These devices are well suited for notebook computer applications: load switching and power management, battery charging circuits, and DC/DC conversion.

Features

- Low gate charge (30nC typical).
- High performance trench technology for extremely low $R_{\text{DS(ON)}}$

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• High power and current handling capability.

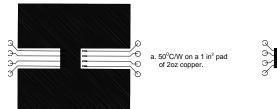


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Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHAR	ACTERISTICS			•			•
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = -250 \mu A$		-30			V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temp. Coefficient	$I_D = -250 \ \mu A$, Referenced	to 25 °C		-22		mV/ºC
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -24 V, V_{GS} = 0 V$				-1	μA
			T _J = 55°C			-10	μA
GSSF	Gate - Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
GSSR	Gate - Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$				-100	nA
ON CHARAC	CTERISTICS (Note 2)						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$		-1	-1.7	-3	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Temp. Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to $25 \ ^{\circ}\text{C}$			4.3		mV/°C
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -11 \text{ A}$			0.011	0.014	Ω
			T _J =125°C		0.016	0.023	
		$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -9 \text{ A}$	1.2		0.015	0.02	
D(ON)	On-State Drain Current	$V_{GS} = -10 \text{ V}, V_{DS} = -5 \text{ V}$		-50			Α
J _{FS}	Forward Transconductance	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -11 \text{ A}$			32		S
DYNAMIC C	HARACTERISTICS				•		
C _{iss}	Input Capacitance	$V_{DS} = -15 V, V_{GS} = 0 V,$			3000		pF
C _{oss}	Output Capacitance	f = 1.0 MHz			870		pF
C _{rss}	Reverse Transfer Capacitance				360		pF
SWITCHING	CHARACTERISTICS (Note 2)						
D(on)	Turn - On Delay Time	$V_{\rm DS} = -15 \text{ V}, \text{ I}_{\rm D} = -1 \text{ A}$ $V_{\rm GEN} = -10 \text{ V}, \text{ R}_{\rm GEN} = 6 \Omega$			12	22	ns
r	Turn - On Rise Time				16	27	ns
D(off)	Turn - Off Delay Time				50	80	ns
f	Turn - Off Fall Time				100	140	ns
С ^а	Total Gate Charge	$V_{DS} = -15 \text{ V}, \text{ I}_{D} = -11 \text{ A},$			30	42	nC
λ_{gs}	Gate-Source Charge	V _{GS} =-5 V			9		nC
\mathcal{Q}_{gd}	Gate-Drain Charge				11		nC
RAIN-SOUI	RCE DIODE CHARACTERISTICS AND MAXIM	UM RATINGS					
s	Maximum Continuous Drain-Source Diode Forward Current					-2.1	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = -2.1 A$ (Not	e 2)		-0.72	-1.2	V

Notes:

1. R_{g,M} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{g,C} is guaranteed by design while R_{gCA} is determined by the user's board design.

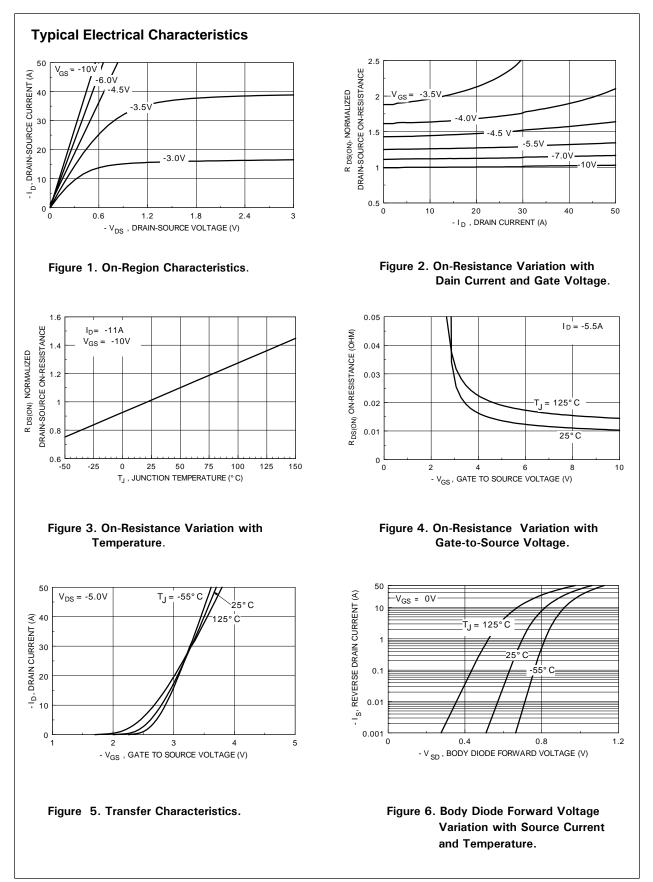




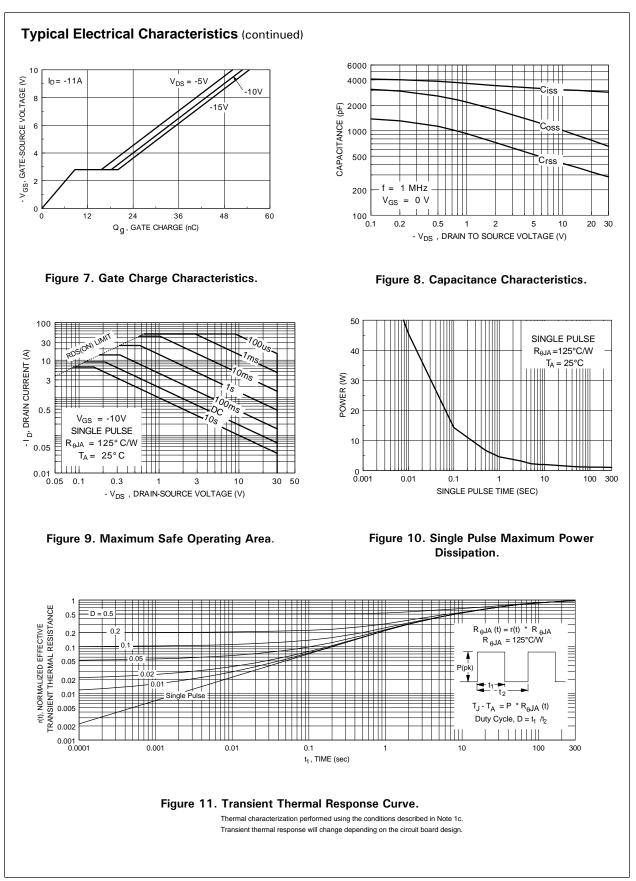
b. 105°C/W on a 0.04 in² pad of 2oz copper.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width $\underline{<}$ 300 $\!\mu s,$ Duty Cycle $\underline{<}$ 2.0%.



FDS6675 Rev.C1



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